

**Search Notes**

Application/Control No.

10/045,517

Examiner

Harold Kim

Applicant(s)/Patent under  
Reexamination

WHITE ET AL.

Art Unit

2181

**SEARCHED**

Class	Subclass	Date	Examiner
710	36, 107, 110, 113, 305	2/6/2005	HK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
710	110, 36	2/6/2005	HK
710	305	2/6/2005	HK

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT, JPO, EPO, IEEE, NPL, USPGPUB, Inventor search on eDAN	2/6/2005	HK